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Application/Control No.	Applicant(s)/Patent under Reexamination
10/553,700	MURASHIMA, ATSUSHI
Examiner	Art Unit
Daniel D. Abebe	2626

	SEAR	CHED	
Class	Subclass	Date	Examiner
704	221, 500	11/12/2006	DA
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
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WEST	11/1	2/2006	DA
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